

Analyzing the Overfitting of Boosted Decision Trees for the Modelling of Stencil Printing

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Abstract

Stencil printing is one of the key steps in reflow soldering technology, and by the spread of ultra-fine-pitch components, analysis of this process is essential. The process of stencil printing has been investigated by a machine learning technique utilizing the ensemble method of boosted decision trees. The phenomenon of overfitting, which can alter the prediction error of boosted decision trees has also been analyzed in detail. The training data set was acquired experimentally by performing stencil printing using different printing speeds (from 20 to 120 mm/s) and various types of solder pastes with different particle sizes (particle size range 25–45 μm , 20–38 μm , 15–25 μm) and different stencil aperture sizes, characterized by their area ratio (from 0.35 to 1.7). The overfitting phenomenon was addressed by training by using incomplete data sets, which means that a subset of data corresponding to a particular input parameter value was excluded from the training. Four cases were investigated with incomplete data sets, by excluding the corresponding data subsets for: area ratios of 0.75 and 1.3, and printing speeds of 70 mm/s and 85 mm/s. It was found that the prediction error at input parameter values that have been excluded from the training can be lowered by eliminating the overfitting; though, the decrease in the prediction error depends on the rate of change in the output parameter in the vicinity of the respective input parameter value.

Keywords

stencil printing, machine learning, decision tree, boosted decision trees, overfitting

1 Introduction

The mass manufacturing of electronic circuits is dominated by the usage of surface mount technology nowadays, in which the components are connected to the printed circuit board by reflow soldering technology [1, 2]. The essence of this technology is that the solder material is provided onto the assembly board in a paste form, the electronic components are placed into the deposited solder paste, then the assembly is transported through an oven. The assembly is heated above the melting point of the solder alloy (lead-free ones have been used generally since 2006), the solder melts and wets the metallizations, then it solidifies when the assembly is cooled down at the end of the process, thereby forming the solder joints between the components and the printed circuit board. The component sizes are continuously decreasing in electronics to meet the functional requirements of IoT (Internet of Things) and 5G devices. The decrease in the component sizes challenges the most critical step in reflow soldering technology, namely the (step of) stencil printing [3, 4].

The stencil printing is responsible for the deposition of solder paste (suspension of solder particles and flux vehicle) onto the soldering pads of the printed circuit board. Based on the literature, most of the reflow soldering failures (50–60%) can be rooted to stencil printing, which renders it a process needed to be analyzed and optimized continuously [5]. The need for optimization became even more crucial by the spread of ultra-fine-pitch components (e.g., QFN – Quad Flat No-lead, μBGA – Micro Ball Grid Array) [6], since smaller apertures belong to the assembly of these components, and the solder paste is harder to be deposited through these apertures. As a consequence, the detailed analyzes and thorough optimization of the stencil printing process by new techniques and methods, like machine learning-based methods, is inevitable to comply with the approach of zero-defect manufacturing.

Machine learning-based methods consist of such algorithms (within the field of artificial intelligence), which can evolve through empirical learning (by datasets) and

provide more accurate results. By utilizing the learning dataset, these methods can create a model that can predict the values of parameters or make appropriate decisions without being developed or programmed to the specific subject. Recently, computing resources have been advancing to a level which allows the application of computational demanding methods to predict and optimize the output of non-linear processes. Optimizing in the early design phase of the electronics manufacturing process can greatly increase their first-pass yield, thereby reducing the need for repair and rework. Several ensemble methods (within the field of machine learning) were used for assessing the technology of reflow soldering or stencil printing, like fuzzy logics [7], decision trees or random forests [8] and artificial neural networks [9]. Though, the stencil printing process was modelled either by neglecting the main characteristic of the stencil aperture, namely the area ratio [5], or has been investigated for the application of through-hole components in the pin-in-paste technology [9]. Furthermore, boosted decision tree ensemble methods have though proven to be appropriate for electronics technology processes, they suffered from the risk of overfitting. Consequently, we decided to analyze the effect of overfitting on the predicting capability of boosted decision trees for the process of stencil printing by also taking the area ratio of stencil apertures into consideration.

2 Materials and methods

2.1 Theoretical background

Decision trees construct a categorization for the training instances by forming branches from well-defined true/false questions in a tree structure. In the structure of the decision tree, the letters represent the appropriate instance category, and the branches represent the connection of features that lead to these categories. If the target value is continuous, e.g. in the case of real numbers, the tree is called a regression tree. The common relevant term, CART (Classification and Regression Trees), covers both regression and classification trees [10]. The main advantage of decision trees is that the data do not require any preparation/pre-shaping, and they can easily be applied to large data sets. However, the accuracy and robustness of the method may be lower compared to other approaches.

The so-called hybrid models apply techniques (e.g., boosting or bagging) which help to overcome these disadvantages, while gradient scaling helps to maintain the required low computation time.

The idea of boosting is based on an iterative method, with an input of $\{(\mathbf{x}_i, \mathbf{y}_i)\}_{i=1}^n$ and with a loss function of $L(\mathbf{y}, F(\mathbf{x}))$. The predicting model $F_m(\mathbf{x}) = F_{m-1}(\mathbf{x}) + \gamma_m h_m(\mathbf{x})$ is getting more precise stepwise, while the learner – for example, a decision tree – $h_m(\mathbf{x})$ is aligned by solving the following optimization problem in Eq. (1):

$$\gamma_m = \arg \min_{\gamma} \sum_{i=1}^n L(\mathbf{y}_i, F_{m-1}(\mathbf{x}_i) + \gamma h_m(\mathbf{x}_i)), \quad (1)$$

where $F_m(\mathbf{x})$ is the updated model after iteration step m . Trees with a predefined size are used in gradient boosting, where the base learner is a regression tree $h(\mathbf{x})$ having L leaves. This regression tree divides the \mathbf{x} vector space into L independent regions $\{R_m\}_{m=1}^L$ in every iteration step m . The solution for the minimization problem, in the end, is in Eq. (2) [11]:

$$\gamma_{lm} = \arg \min_{\gamma} \sum_{\mathbf{x}_i \in R_{lm}} L(\mathbf{y}_i, F_{m-1}(\mathbf{x}_i) + \gamma). \quad (2)$$

One can use simple regularization method as well, which defines the contribution of the base learners by using a ν factor [11] as follows in Eq. (3):

$$F_m(\mathbf{x}) = F_{m-1}(\mathbf{x}) + \nu \cdot \gamma_{lm} I(\mathbf{x} \in R_{lm}), \quad (3)$$

where ν is mainly called the "learning rate".

Using a machine learning method means that an optimal solution is sought for a system of equations with several parameters. It can happen that if the parameters are chosen incorrectly, the system is overparameterized, i.e., the so-called overfitting phenomenon occurs [12]. In addition, in the case of overfitting, a seemingly excellent and accurate model and solutions are provided to a given problem – that is, the output data is determined with a high accuracy based on the input data. However, an overfitted model will most likely estimate the output with a high error rate for other input combinations which are not included in the training data set.

There are many approaches for preventing overparameterization. For example, suppose the number of parameters can be reduced so that the accuracy of the model does not deteriorate significantly. In that case, one can avoid overfitting (at the same time) by considering fewer parameters in the teaching, thus utilizing less memory and computational resources. As a result, the required runtime can be reduced significantly. The most common approaches include building a model that consists of the appropriate input parameters but excludes parameters that are not

suitable for the general description of the system. Hence, this approach seeks to reduce the number of parameters used by the training method [13, 14].

Another approach is the partitioning of the data (used for teaching) into multiple data sets to validate the model. During the validation, the efficiency of the created model is examined on these different data sets, so it can be determined if the model has been overfitted on a given set of the training data; the model calculates the output with rather high error rate for one or more validation data sets in this case. Because in this approach the teaching is performed in multiple iterations (a model considered inaccurate during the validation process is rejected and possibly re-training is also initialized), so it may not be applicable for large data sets due to the significant increase in the training time [15].

2.2 The training data set

The data set for training the decision tree-based method was obtained by experiments. Stencil printing was carried out on a testboard by utilizing different printing speeds (in an EKRA X4 stencil printer), stencil aperture sizes, and lead-free solder paste types (varying solder particle diameter), as detailed in the work [16]. The printing speeds were the following: 20, 40, 75, 85, 120 mm/s, and the area ratio of the stencil apertures was varied between 0.35–1.7. The investigated solder paste types were Type-3, Type-4, Type-5, in which the diameter range of the solder particles were 25–45 μm , 20–38 μm , 15–25 μm , respectively. Though, the particle sizes in the different solder paste types were analyzed in detail. The particle diameter distribution was approached by a log-normal distribution, and the parameters of the geometric mean ($\mu_g = e^\mu$) and geometric deviation ($\sigma_g = e^\sigma$) were used for characterizing the different solder paste types quantitatively. The output parameters which determine the quality of the stencil printing process were the area, thickness and volume of the solder paste deposits. These parameters were measured by a Koh-Young aSPIre II solder paste inspection (SPI) machine.

The experimental runs were repeated 5 times, i.e., using 5 testboards for each printing speed and solder paste type. As a result, the experiment yielded a data set with 15 675 vectors consisting of the input and output parameters.

2.3 Analyzing the overfitting of decision trees

Boosted decision trees (using the technique of Least Squares Boosting) were used for the analyzes. The decision tree models were implemented in Matlab and optimized by splitting the input data set into training and test

set stochastically and minimizing the Root Mean Squared Error (RMSE) of the model prediction to the test set.

Besides, a validation data set was created, which consisted of 345 vectors of the input and output parameters, strictly including only one instance of each input parameter value. The output parameter values in the validation set were obtained by calculating the mean of the corresponding output values. The predicting capability of the decision trees (non-boosted and boosted) was characterized by the Mean Absolute Percentage Error of the prediction to the output values in the validation data set.

The phenomenon of overfitting was analyzed by preparing so-called incomplete data sets. This means that one value of an input parameter was omitted entirely from the training together with the corresponding output parameter values. For example, the vectors for the printing speed of 70 mm/s were entirely omitted from the training set. As a second step, the decision trees were trained by this incomplete data set. Finally, the predicting capability was analyzed by setting the excluded value as an input value (e.g., 70 mm/s printing speed) and comparing the predicted output values to the excluded experimental output values. By this method, one can simulate the effect when a new (formerly unknown) input parameter value appears in the process of stencil printing, and the decision trees are used to predict the quality of the printing (area, thickness and volume of solder paste deposits). Incomplete data sets can be created similarly by omitting values of the stencil aperture size (area ratio). By going through the steps mentioned above, one can simulate the effect when a new (formerly unknown) aperture size appears in the manufacturing, e.g. when a new electronic component is introduced into the electronics product. In this investigation, the predicting capability was analyzed for 4 incomplete data sets; by omitting the value of printing speed 70 mm/s or 85 mm/s, or by omitting the value of area ratio 0.75 or 1.3 (always omitting only one input value at once).

Training by incomplete data sets can reveal the phenomenon of overfitting immediately. If the output values are predicted for an input value included in the training set, the prediction error is expected to be low. Contrary, if the output values are predicted for an input value which was excluded from the training, the predicting error is expected to be relatively high. By eliminating the phenomenon of overfitting, the predicting error at input values included in the training can be slightly higher, but the prediction error at an input value excluded from the training can be lower at the same time. The elimination of overfitting was solved

in this investigation by changing the training parameters and evaluating the changes of the prediction error for both omitted and included input data combinations in different training data sets. Learning parameters for the boosted decision trees were: minimum leaf size, learning rate and number of learning iterations. Overfitting may occur if minimum leaf size and learning rate are low, while the number of learning iterations is high. Hence, if validation for omitted input parameters showed a high error rate, parameters for the minimum leaf size and learning rate were increased and the number of learning iterations were decreased to prevent overfitting by also analysing the changes in error rate for multiple validation data sets in multiple training iterations for various training data.

3 Results and discussion

The phenomenon of overfitting was investigated for boosted decision trees. By analyzing the mean absolute percentage of the prediction for incomplete data sets the phenomenon of overfitting was found. Fig. 1 and Fig. 2 illustrate the prediction error for the cases when data vectors corresponding

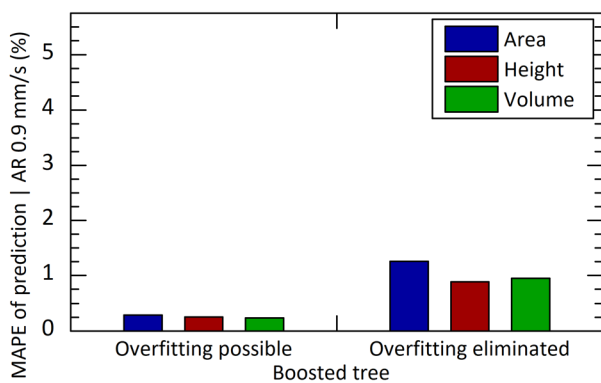


Fig. 1 Prediction error of area, height and volume of deposited solder paste at a stencil aperture area ratio 0.9 (the data subset for AR 0.75 has been excluded from the training)

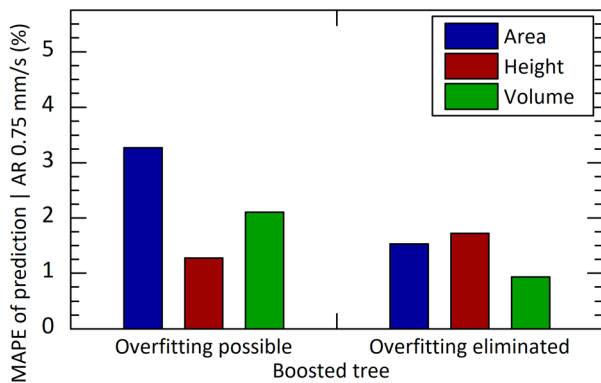


Fig. 2 Prediction error of area, height and volume of deposited solder paste at a stencil aperture area ratio 0.75 (the data subset for AR 0.75 has been excluded from the training)

to the stencil aperture area ratio of 0.75 were excluded. In Fig. 1, the prediction error for AR 0.9 is illustrated – presenting the case when the output parameters (area, thickness, volume) are predicted for an input parameter value that has been included in the training.

On the contrary, the prediction error for AR 0.75 is illustrated in Fig. 2 – presenting the case when the output parameter values are predicted for an input parameter value that has been excluded from the training.

As it can be observed in Figs. 1 and 2, when the overfitting is not eliminated, boosted decision trees can predict the quality of stencil printing with low error, [below 1% (Fig. 1 left part)] for input parameters that have been included in the data set. On the contrary, the prediction error is much higher for an input parameter value that has not been included in the training (simulating when a new input parameter value is introduced in the process); the prediction error can reach 3% (Fig. 2 left part).

If the overfitting is eliminated, the prediction capability of boosted trees can be enhanced for the process of stencil printing. The prediction error can be lowered from 2.2% to 1.4% in average for an input parameter value (AR 0.75) that has not been included in the training set, as illustrated in the right part of Fig. 2. Nevertheless, eliminating the overfitting can increase the prediction error, particularly for the input parameter values included in the training, as illustrated in the right part of Fig. 1. Generally, if boosted tree-based prediction is necessary for a process parameter value that is not available at the moment but is expected to be introduced in the future, overfitting can be eliminated.

Nevertheless, eliminating overfitting may not reduce the prediction error for excluded parameter values but does not significantly increase the error either. Fig. 3 illustrates the prediction error for the stencil aperture area ratio of 1.3 (in this case, this value was excluded from the training).

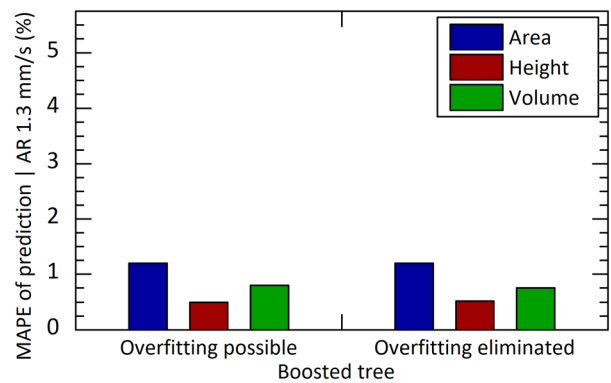


Fig. 3 Prediction error of area, height and volume of deposited solder paste at a stencil aperture area ratio 1.3 (the data subset for AR 1.3 has been excluded from the training)

This can be because the change of output values (area, thickness, volume) is lower in the vicinity of the specific input value; that is, the slope of the output function is lower at that region. Fig. 4 illustrates the area, height and volume of solder paste deposits as functions of stencil aperture area ratio. As it can be seen, the slope or the change in the function is much pronounced at the area ratio of 0.7 than at the ratio of 1.3 (indicated by orange dashed lines), except for the parameter of height. If Fig. 2 is reanalyzed, it can be found there too that the prediction error of height was not decreased by eliminating overfitting.

The prediction error of boosted trees was analyzed for such incomplete data sets also in which data vectors were excluded for specific printing speeds (not for particular area ratios). Figs. 5–7 illustrate the corresponding prediction errors. At first, a case is presented in Fig. 5, where the specific printing speed was included in the training.

Like when data vectors for particular area ratios were excluded, the prediction error is increasing for input

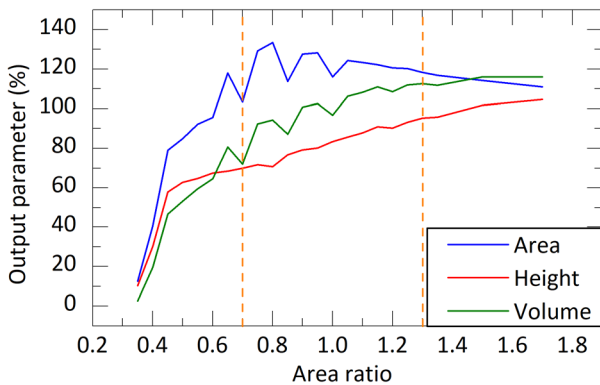


Fig. 4 Output parameters as a function of stencil aperture area ratio (note, the percentage value for the height is calculated by dividing the height values by 150 μm , which is the stencil thickness)

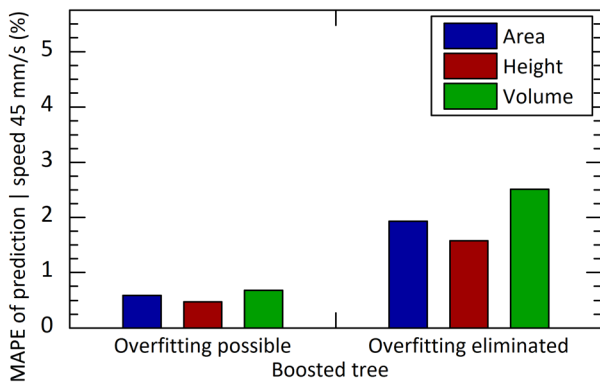


Fig. 5 Prediction error of area, height and volume of deposited solder paste at a printing speed of 45 mm/s (the data subset for speed 70 mm/s has been excluded from the training)

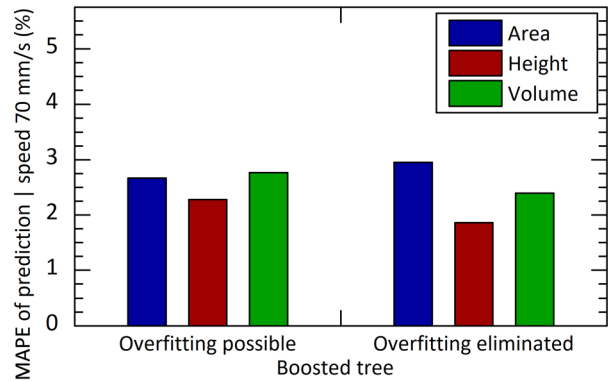


Fig. 6 Prediction error of area, height and volume of deposited solder paste at a printing speed of 70 mm/s (the data subset for speed 70 mm/s has been excluded from the training)

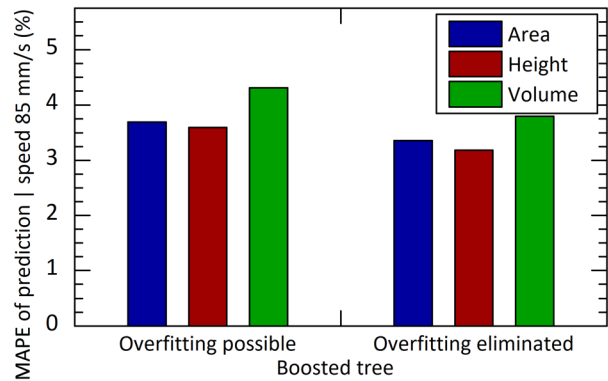


Fig. 7 Prediction error of area, height and volume of deposited solder paste at a printing speed of 85 mm/s (the data subset for speed 85 mm/s has been excluded from the training)

values that have been included in the training by eliminating the overfitting; from $\sim 0.6\%$ to 2% in this case. Fig. 6 and Fig. 7 illustrate the prediction error for printing speeds which were not included in the training.

By eliminating overfitting, no significant decrease in the prediction error was found at the printing speed of 70 mm/s, i.e., using an input parameter which was excluded from the training. Similar results were obtained with the printing speed of 85 mm/s. The change in the average prediction error of the output parameters (mean of error for the area, height and volume) for the two printing speeds were $2.57\% \rightarrow 2.4\%$ and $3.85\% \rightarrow 3.45\%$, respectively.

The reason for the insignificant decrease in the prediction error (by eliminating overfitting) is the same as in the case presented in Fig. 3, that is, the output parameters (area, height, volume) do not change significantly as the function of the input parameter (printing speed), as illustrated in Fig. 8.

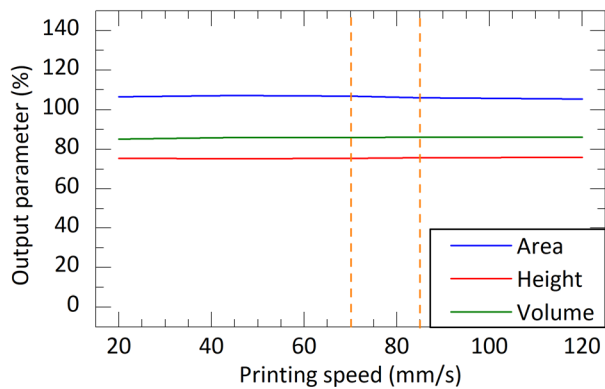


Fig. 8 Output parameters as a function of printing speed (note, the percentage value for the height is calculated by dividing the height values by 150 μm , which is the stencil thickness)

4 Conclusion

Boosted decision trees have been investigated for predicting the quality of stencil printing, and the phenomenon of overfitting was analyzed, which can alter the performance of boosted trees and the prediction error. Generally, overfitting causes problems (high prediction error) only if the

outputs of a process are needed to be predicted for input parameter values that cannot be included in the training data set, because they are not available at the time of training. Specifically, if the outputs change rapidly in the vicinity of a particular input value, high prediction error is expected for that input if overfitting is not eliminated. On the other hand, if the change in the output is small, or all the inputs are / can be included in the training, a possible overfitting does not yield in the increase of prediction error. In this case, the decision tree can be utilized without overfitting, providing faster predictions.

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